

Amended Initial PCN

Key Foundry Co., Ltd. BEOL (Back End of Line) Process Change

Dear Customer,

Amendment Note: The Initial PCN has been amended to remove part numbers no longer associated with the BEOL Process Change. The qualification plan has also been adjusted accordingly. The specific part numbers removed are denoted with a text strikethrough in Appendix A and have been eliminated from the list in Appendix B. There are no other adjustments.

The Key Foundry Co., Ltd., the BEOL (Back End of Line) process is being aligned and enhanced with the adoption of a new Process of Record (POR) for all products manufactured with technologies greater than 250 nano-meters:

Category	Module	Process	Current POR	New POR			
	IMD Module	Gap Fill	SOG (Spin on Glass)	HDP CVD (Chemical Vapor Deposition)			
Process Change	(Inter-Metal Dielectric)	IMD Planarization	CMP	CMP			
Process Change	Via Module	W Fill	W CVD	W CVD			
		W (Tungsten) Removal	Etch Back =	CMP (Chemical Mechanical Polish)			

The Initial PCN notification describes and includes the details associated with the change and qualification process. The qualification process will be carried out at a technology level and will follow the Cirrus Logic qualification guidelines and meet the JEDEC standards as well as AEC-Q100 as applicable.

Special Note 1: The orderable part numbers for this material will change and are depicted in Appendix B*. However, the symbolization on the physical part number will not change.

Special Note 2: Due to current capacity constraints, it is strongly recommended that desired sample quantities are communicated back to Cirrus Logic within 60 days of the Initial PCN notification.

If you have any questions, please contact your Sales Representative.

Sincerely,

Quality Systems Administrator Cirrus Logic Corporate Quality Phone: +1(512) 851-4000

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^{*} Cirrus Logic part numbers have been updated to reflect available material



Products Affected:

The devices listed on this page are the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

Technical details of this Process / Product Change follow on the next page(s).

Title	itle: Key Foundry Co., Ltd. BEOL (Back End of Line) Process Change									
Customer Contact: Local Field Sales			Representative Phone: (512) 851-40		1000	Dept:	Cor	porate Quality		
Pro	posed 1 st Ship Da	ite:	Q3_2022 (CY) Estimated Sample A		Availa	vailability Date: Q2_2022 (CY)		Q2_2022 (CY)		
Cha	nge Type:									
	Assembly Site			Assembly Process			Assembly Materials			
	Wafer Fab Site			X Wafer Fab Process			Wafer Fab Materials			
Wafer Bump Site			Wafer Bump Process			Wafer Bump Material		Material		
Test Site			Test Process			Design				
Electrical Specification			Mechanical Specification		Х	Part Number (Orderable Only-Reference Appendix B)				
Packing/Shipping/Labeling			Other						·	
Con	Comments: BEOL (Back End of Line) Process Change									

PCN Details

Description of Change:

BEOL (Back End of Line) Process Change:

IMD Module Gap Fill

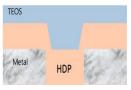
From: SOG (Spin On Glass)





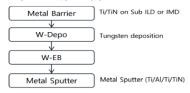
To: HDP CVD (Chemical Vapor Deposition)



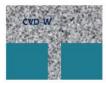


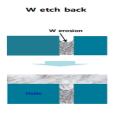
Via Module W(Tungsten) Removal

From: Etch Back



CVD-W Deposition

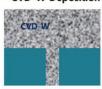


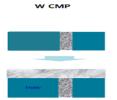


To: CMP (Chemical Mechanical Polish)



CVD-W Deposition





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Reason for Change:							
Better process capability:							
Alignment and enhancement for all process technologies greater than 250 nanometers. Note: Key Foundry Co., Ltd. will not qualify a new SOG supplier.							
Anticipated Impact on Form, Fit, Function, Quality or Reliability:							
No anticipated adverse impact to the Quality and/or Reliability of said product as the given processes exist and are mature for existing smaller technologies.							
Anticipated Impact on Material Declaration:							
 ✓ No Impact to the Material Declarations or Product Content reports are driven from production data and will be available following the production release. 							
Product Affected:							
Reference Appendix A Special Note: The orderable part numbers for this material are depicted in Appendix B. However, the symbolization on the physical part number will not change. Datasheet(s) will be updated accordingly to reflect the orderable part							
number(s).							
Changes To Product Identification Resulting From This PCN:							
No change to product identification							
Qualification Data:							
This qualification has been specifically developed for the validation of this change. The qualification							

data validates that the proposed change meets the applicable released technical specifications.

Qualification Schedule Start: Q3_3	2021 (CY) End:	End of Q4_2021 (CY)
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Qualification Device Matrix							
Detail Description	Device 1	Device 2	Device 3	Device 4			
Description:	Codec	Codec	ADC	Volume Control			
Wafer Fab Site Code/Name:	YF	YF	YF	YF			
	(Key Foundries)	(Key Foundries)	(Key Foundries)	(Key Foundries)			
Wafer Technology:	0.30 um	0.35 um	0.35 um	0.35 um			
	CMOS	CMOS	CMOS	CMOS (HV)			
Die Size:	6.27 mm	22.29 mm	6.42 mm	12.15 mm			
Package Type/Code:	24 QFN	64L QFP	24 TSSOP	48L QFP			
Moisture Level:	MSL 3	MSL 3	MSL 3	MSL 3			

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The Qualification Plans are designed using JEDEC and other applicable industry standards. An overall summary of the Qualification results will be submitted upon completion.

Device Matrix Qualification

Qualification: 🛛 Plan 🔲 Test Results							
Reliability Test	Standard	Conditions	Sample Size (PASS/FAIL)				
	IEDEC						
PC + TC (MSL3 + Temperature Cycle)	JEDEC J-STD-020A + JESD22 A104	-65°C to +150°C for 500 cycles (77 units per qual matrix)	308 / #				
HTSL (High Temperature Storage Life)	JESD22 A103	150°C for 1000 hrs (77 units per qual matrix)	308/#				
HTOL (High Temperature Operating Life)	JESD22 A108	125°C Ta for 1000 hours at Vmax (77 units per qual matrix)	308/#				
ELFR (Early Life Fail Rate)	JESD22 A108	125°C Ta for 48 hours at Vmax op	2400 / #				
HBM (Human Body Model)	JESD22 A114	2000V (3 units per qual matrix)	12 / #				
CDM (Charge Device Model)	JESD22 C101	500V / 750V (Corner Pins) (3 units per qual matrix)	12 / #				
LU VDD (Latch Up VDD)	JESD78	1.5*Vnom (3 units per qual matrix)	12 / #				
LU I/O (Latch Up Input/Output)	JESD78	200mA, 1A on high power pins (3 units per qual matrix)	12 / #				
WBP (Wire Bond Pull)	MIL-STD-883 Method 2011	Paragraph 3 (Procedure) (5 units per qual matrix)	20/#				
Post Temp WBP (Wire Bond Pull)	MIL-STD-883 Method 2011	Paragraph 3 (Procedure) (5 units per qual matrix)	20/#				

Notes:

- Qualification tests "pass" on zero fails for each test
- The Qualification Device Matrix on the preceding page serves as the Qualification Vehicle for all part numbers depicted in the respective Appendix.

Reliability Qualification Results:

Pending Completion of Qualification

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Appendix A

The devices listed on this page are the complete list of affected devices. According to our records, these are the devices that you may have purchased within the past twenty-four (24) months.

Product Affected:

	Appendix A - Cirrus Logic Part Number(s)							
1	CS3308-CQZ	30	CS4392-KZZR	59	CS5460C-ISZ			
2	CS3308-CQZR	31	CS4398-CZZ	60	CS5460C-ISZR			
3	CS3318-CQZ	32	CS4398-CZZR	61	CS5461A-ISZ			
4	CS3318-CQZR	33	CS5345-CQZ	62	CS5461A-ISZR			
5	CS4245-CQZ	34	CS5345-CQZR	63	CS5463-ISZ			
6	CS4245-CQZR	35	CS5346-CQZ	64	CS5463-ISZR			
7	CS4245-DQZ	36	CS5346-CQZR	65	CS5464-ISZ			
8	CS4245-DQZR	37	CS5346-DQZ	66	CS5464-ISZR			
9	CS42516-CQZ	38	CS5346-DQZR	67	CS5467-ISZ			
10	CS42516-CQZR	39	CS5351-DZZ	68	CS5467-ISZR			
11	CS42518-CQZ	40	CS5351-DZZR	69	CS5550-ISZ			
12	CS42518-CQZR	41	CS5351-KSZ	70	CS5550-ISZR			
13	CS42526-CQZ	42	CS5351-KSZR	71	CS8416-CNZ			
14	CS42526-CQZR	43	CS5351-KZZ	72	CS8416-CNZR			
15	CS42528-CQZ	44	CS5351-KZZR	73	CS8416-CSZ			
16	CS42528-CQZR	45	CS5361-DZZ	74	CS8416-CSZR			
17	CS4265-CNZ	46	CS5361-DZZR	75	CS8416-CZZ			
18	CS4265-CNZR	47	CS5361-KSZ	76	CS8416-CZZR			
19	CS4265-DNZ	48	CS5361-KSZR	77	CS8416-DZZ			
20	CS4265-DNZR	49	CS5361-KZZ	78	CS8416-DZZR			
21	CS4271-CZZ	50	CS5361-KZZR	79	CS8900A-CQ3Z			
22	CS4271-CZZR	51	CS5363-DZZ	80	CS8900A-CQ3ZR			
23	CS4271-DZZ	52	CS5363-DZZR	81	CS8900A-CQZ			
24	CS4271-DZZR	53	CS5381-KSZ	82	CS8900A-CQZR			
25	CS4272-CZZ	54	CS5381-KSZR	83	CS8900A-IQ3Z			
26	CS4272-CZZR	55	CS5381-KZZ	84	CS8900A-IQ3ZR			
27	CS4272-DZZ	56	CS5381-KZZR	85	CS8900A-IQZ			
28	CS4272-DZZR	57	CS5460A-BSZ	86	CS8900A-IQZR			
29	CS4392-KZZ	58	CS5460A-BSZR	87	WM8940CGEFL/RV			
				88	WM8940CGEFL/V			

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Appendix B

The devices listed on this page are the new orderable part numbers that will replace the affected devices listed in Appendix A

Product Affected:

	Appendix B - Cirrus Logic New Orderable Part Number(s)							
1	CS3308 K -CQZ	30	CS4392 K -KZZR	59	CS5460C K -ISZ			
2	CS3308 K -CQZR	31	CS4398 K -CZZ	60	CS5460C K -ISZR			
3	CS3318 K -CQZ	32	CS4398 K -CZZR	61	CS5461A K -ISZ			
4	CS3318 K -CQZR	33	CS5345 K -CQZ	62	CS5461A K -ISZR			
5	CS4245 K -CQZ	34	CS5345 K -CQZR	63	CS5463 K -ISZ			
6	CS4245 K -CQZR	35	CS5346 K -CQZ	64	CS5463 K -ISZR			
7	CS4245 K -DQZ	36	CS5346 K -CQZR	65	CS5464 K -ISZ			
8	CS4245 K -DQZR	37	CS5346 K -DQZ	66	CS5464 K -ISZR			
9	CS42516 K -CQZ	38	CS5346 K -DQZR	67	CS5467 K -ISZ			
10	CS42516 K -CQZR	39	CS5351 K -DZZ	68	CS5467 K -ISZR			
11	CS42518 K -CQZ	40	CS5351 K -DZZR	69	CS5550 K -ISZ			
12	CS42518 K -CQZR	41	CS5351 K -KSZ	70	CS5550 K -ISZR			
13	CS42526 K -CQZ	42	CS5351 K -KSZR	71	CS8416 K -CNZ			
14	CS42526 K -CQZR	43	CS5351 K -KZZ	72	CS8416 K -CNZR			
15	CS42528 K -CQZ	44	CS5351 K -KZZR	73	CS8416 K -CSZ			
16	CS42528 K -CQZR	45	CS5361 K -DZZ	74	CS8416 K -CSZR			
17	CS4265 K -CNZ	46	CS5361 K -DZZR	75	CS8416 K -CZZ			
18	CS4265 K -CNZR	47	CS5361 K -KSZ	76	CS8416 K -CZZR			
19	CS4265 K -DNZ	48	CS5361 K -KSZR	77	CS8416 K -DZZ			
20	CS4265 K -DNZR	49	CS5361 K -KZZ	78	CS8416 K -DZZR			
21	CS4271 K -CZZ	50	CS5361 K -KZZR	79				
22	CS4271 K -CZZR	51	CS5363 K -DZZ	80				
23	CS4271 K -DZZ	52	CS5363 K -DZZR	81				
24	CS4271 K -DZZR	53	CS5381 K -KSZ	82				
25	CS4272 K -CZZ	54	CS5381 K -KSZR	83				
26	CS4272 K -CZZR	55	CS5381 K -KZZ	84				
27	CS4272 K -DZZ	56	CS5381 K -KZZR	85				
28	CS4272 K -DZZR	57	CS5460A K -BSZ	86				
29	CS4392 K -KZZ	58	CS5460A K -BSZR	87	WM8940 K GEFL/RV			
				88	WM8940 K GEFL/V			

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